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## MR27V801D

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1,048,576-Word x 8-Bit One Time PROM

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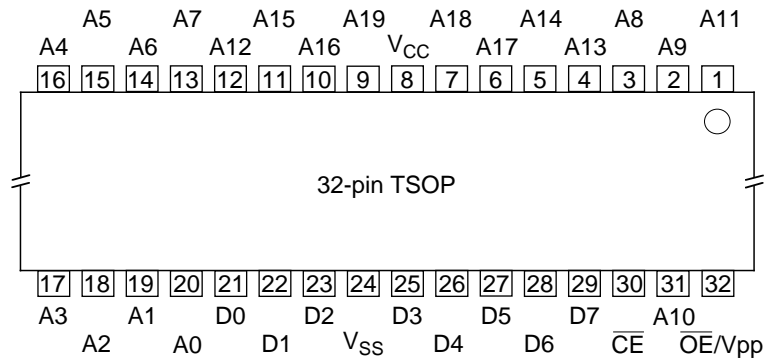
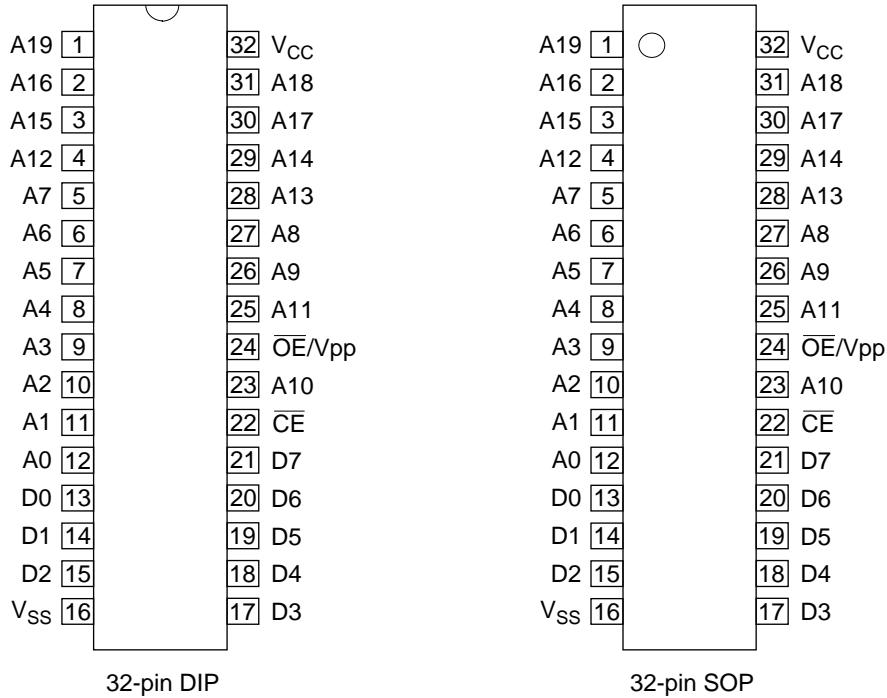
### DESCRIPTION

The MR27V801D is a 8Mbit electrically Programmable Read-Only Memory organized as 1,048,576 word x 8bit. The MR27V801D operates on a single +3V-3.3V power supply and is TTL compatible. Since the MR27V801D operates asynchronously, external clocks are not required, making this device easy-to-use. The MR27V801D is suitable as large-capacity fixed memory for microcomputers and data terminals. It is manufactured using a CMOS double silicon gate technology and is offered in 32-pin DIP, 32-pin SOP or 32-pin TSOP packages.

### FEATURES

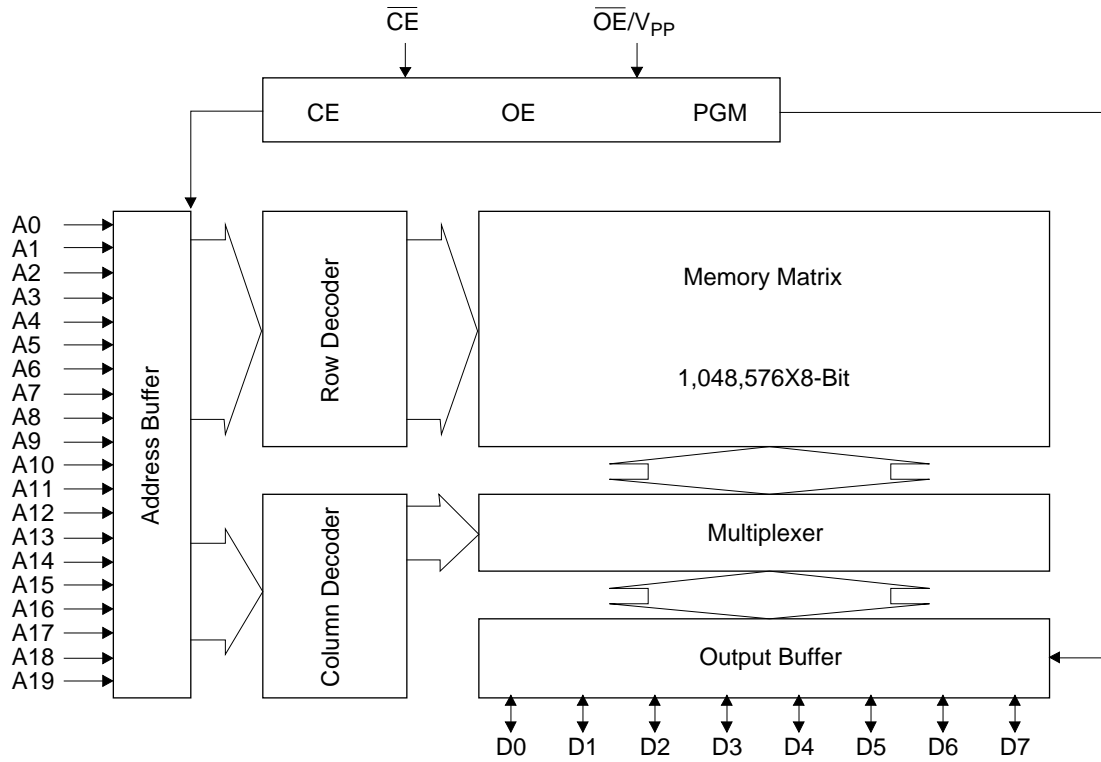
- 1,048,576 word x 8bit
- Single +3V-3.3V power supply
- Access time           100ns access time (Vcc=+3V)  
                              80ns access time (Vcc=+3.3V)
- Input / Output TTL compatible
- Three-state output
- Packages                32-pin plastic DIP (DIP32-P-600-2.54)           (Product name : MR27V801DRA)  
                              32-pin plastic SOP (SOP32-P-525-1.27-K)       (Product name : MR27V801DMA)  
                              32-pin plastic TSOP (TSOP I 32-P-814-0.50-K) (Product name : MR27V801DTA)

## PIN CONFIGURATION (TOP VIEW)



PIN NAMES	FUNCTIONS
A0 - A19	Address input
D0 - D7	Data output
CE	Chip enable
OE/V <sub>PP</sub>	Output enable / Program power supply voltage
V <sub>CC</sub>	Power supply voltage
V <sub>SS</sub>	GND

## BLOCK DIAGRAM



## FUNCTION TABLE

MODE	$\overline{CE}$	$\overline{OE}/V_{PP}$	$V_{CC}$	D0 - D7
READ	L	L	3.0V to 3.3V	$D_{OUT}$
OUTPUT DISABLE	L	H		Hi-Z
STAND-BY	H	*		Hi-Z
PROGRAM	L	9.75V	4.0V	$D_{IN}$
PROGRAM INHIBIT	H			Hi-Z
PROGRAM VERIFY	L	L		$D_{OUT}$

\*: Don't Care

**ABSOLUTE MAXIMUM RATINGS**

Parameter	Symbol	Condition	Value	Unit
Operating temperature under bias	$T_{opr}$	-	0 to 70	°C
Storage temperature	$T_{stg}$		-55 to 125	°C
Input voltage	$V_I$	relative to $V_{SS}$	-0.5 to $V_{CC} + 0.5$	V
Output voltage	$V_O$		-0.5 to $V_{CC} + 0.5$	V
Power supply voltage	$V_{CC}$		-0.5 to 5	V
Program power supply voltage	$V_{PP}$		-0.5 to 11.5	V
Power dissipation per package	$P_D$	-	1.0	W

**RECOMMENDED OPERATING CONDITIONS**

(Ta=0 to 70°C)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
$V_{CC}$ power supply voltage	$V_{CC}$	$V_{CC}=2.7V - 3.6V$	2.7	-	3.6	V
$V_{PP}$ power supply voltage	$\overline{OE}/V_{PP}$		-0.5	-	$V_{CC}+0.5$	V
Input "H" level	$V_{IH}$		2.2	-	$V_{CC}+0.5^*$	V
Input "L" level	$V_{IL}$		-0.5**	-	0.6	V

Voltage is relative to  $V_{SS}$ \* :  $V_{CC}+1.5V$  (Max.) when pulse width of overshoot is less than 10nS.

\*\* : -1.5V (Min.) when pulse width of undershoot is less than 10nS.

## ELECTRICAL CHARACTERISTICS (Read operation)

### DC Characteristics 1

( $V_{CC}=3V\pm 0.3V$ ,  $T_a=0$  to  $70^\circ C$ )

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input leakage current	$I_{LI}$	$V_I=0$ to $V_{CC}$	-	-	10	$\mu A$
Output leakage current	$I_{LO}$	$V_O=0$ to $V_{CC}$	-	-	10	$\mu A$
$V_{CC}$ power supply current (Standby)	$I_{CCSC}$	$\overline{CE}=V_{CC}$	-	-	50	$\mu A$
	$I_{CCST}$	$\overline{CE}=V_{IH}$	-	-	1	mA
$V_{CC}$ power supply current (Read)	$I_{CCA}$	$\overline{CE}=V_{IL}$ , $\overline{OE}/V_{PP}=V_{IH}$ $t_c=100ns$	-	-	25	mA
$V_{PP}$ power supply current	$I_{PP}$	$\overline{OE}/V_{PP}=V_{CC}$	-	-	10	$\mu A$
Input "H" level	$V_{IH}$	-	2.2	-	$V_{CC}+0.5^*$	V
Input "L" level	$V_{IL}$	-	-0.5**	-	0.6	V
Output "H" level	$V_{OH}$	$I_{OH}=-400\mu A$	2.4	-	-	V
Output "L" level	$V_{OL}$	$I_{OL}=2.1mA$	-	-	0.4	V

Voltage is relative to Vss

\* :  $V_{CC}+1.5V$  (Max.) when pulse width of overshoot is less than 10nS.

\*\* : -1.5V (Min.) when pulse width of undershoot is less than 10nS.

### DC Characteristics 2

( $V_{CC}=3.3V\pm 0.3V$ ,  $T_a=0$  to  $70^\circ C$ )

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input leakage current	$I_{LI}$	$V_I=0$ to $V_{CC}$	-	-	10	$\mu A$
Output leakage current	$I_{LO}$	$V_O=0$ to $V_{CC}$	-	-	10	$\mu A$
$V_{CC}$ power supply current (Standby)	$I_{CCSC}$	$\overline{CE}=V_{CC}$	-	-	50	$\mu A$
	$I_{CCST}$	$\overline{CE}=V_{IH}$	-	-	1	mA
$V_{CC}$ power supply current (Read)	$I_{CCA}$	$\overline{CE}=V_{IL}$ , $\overline{OE}/V_{PP}=V_{IH}$ $t_c=80ns$	-	-	30	mA
$V_{PP}$ power supply current	$I_{PP}$	$\overline{OE}/V_{PP}=V_{CC}$	-	-	10	$\mu A$
Input "H" level	$V_{IH}$	-	2.2	-	$V_{CC}+0.5^*$	V
Input "L" level	$V_{IL}$	-	-0.5**	-	0.6	V
Output "H" level	$V_{OH}$	$I_{OH}=-400\mu A$	2.4	-	-	V
Output "L" level	$V_{OL}$	$I_{OL}=2.1mA$	-	-	0.4	V

Voltage is relative to Vss

\* :  $V_{CC}+1.5V$  (Max.) when pulse width of overshoot is less than 10nS.

\*\* : -1.5V (Min.) when pulse width of undershoot is less than 10nS.

**AC Characteristics 1**(V<sub>CC</sub>=3V±0.3V, Ta=0 to 70°C)

Parameter	Symbol	Condition	Min.	Max.	Unit
Address cycle time	T <sub>C</sub>	-	100	-	ns
Address access time	T <sub>ACC</sub>	$\overline{CE}=\overline{OE}/V_{PP}=V_{IL}$	-	100	ns
$\overline{CE}$ access time	T <sub>CE</sub>	$\overline{OE}/V_{PP}=V_{IL}$	-	100	ns
$\overline{OE}$ access time	T <sub>OE</sub>	$\overline{CE}=V_{IL}$	-	50	ns
Output disable time	T <sub>CHZ</sub>	$\overline{OE}/V_{PP}=V_{IL}$	0	30	ns
	T <sub>OHZ</sub>	$\overline{CE}=V_{IL}$	0	25	ns
Output hold time	T <sub>OH</sub>	$\overline{CE}=\overline{OE}/V_{PP}=V_{IL}$	0	-	ns

## Measurement conditions

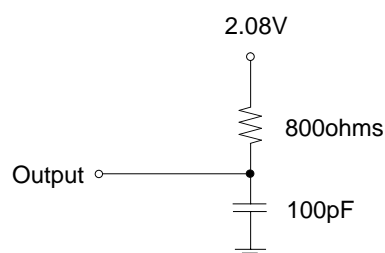
Input signal level	-----	0V/3V
Input timing reference level	-----	0.8V/2.0V
Output load	-----	100pF
Output timing reference level	-----	0.8V/2.0V

**AC Characteristics 2**(V<sub>CC</sub>=3.3V±0.3V, Ta=0 to 70°C)

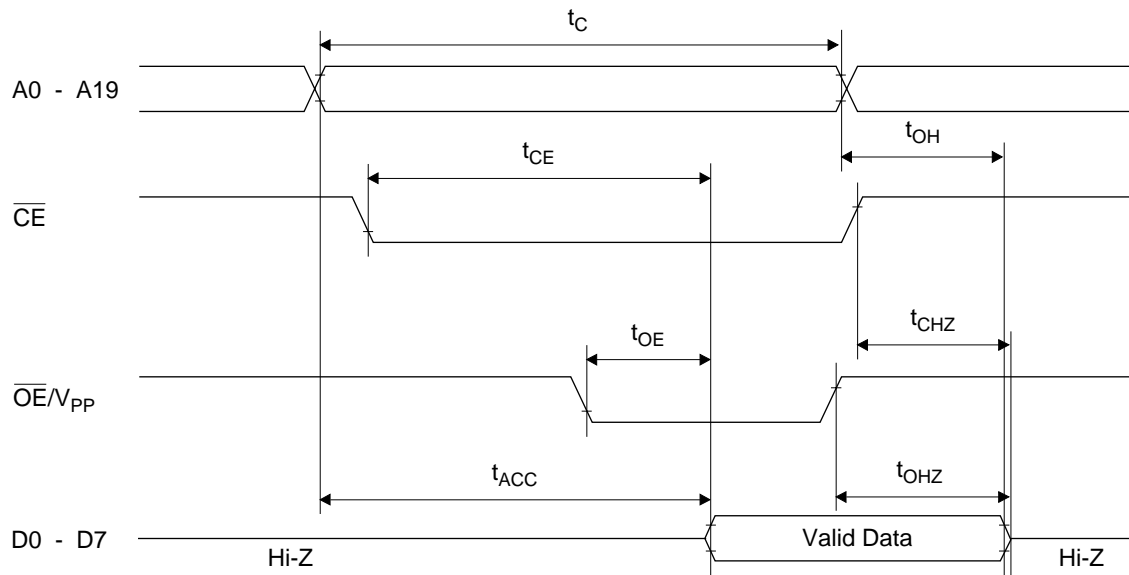
Parameter	Symbol	Condition	Min.	Max.	Unit
Address cycle time	T <sub>C</sub>	-	80	-	ns
Address access time	T <sub>ACC</sub>	$\overline{CE}=\overline{OE}/V_{PP}=V_{IL}$	-	80	ns
$\overline{CE}$ access time	T <sub>CE</sub>	$\overline{OE}/V_{PP}=V_{IL}$	-	80	ns
$\overline{OE}$ access time	T <sub>OE</sub>	$\overline{CE}=V_{IL}$	-	40	ns
Output disable time	T <sub>CHZ</sub>	$\overline{OE}/V_{PP}=V_{IL}$	0	30	ns
	T <sub>OHZ</sub>	$\overline{CE}=V_{IL}$	0	25	ns
Output hold time	T <sub>OH</sub>	$\overline{CE}=\overline{OE}/V_{PP}=V_{IL}$	0	-	ns

## Measurement conditions

Input signal level	-----	0V/3V
Input timing reference level	-----	0.8V/2.0V
Output load	-----	100pF
Output timing reference level	-----	0.8V/2.0V



## TIMING CHART (READ CYCLE)



## PIN Capacitance

(V<sub>CC</sub>=3.3V, T<sub>a</sub>=25°C, f=1MHz)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input	C <sub>IN1</sub>	V <sub>I</sub> =0V	-	-	8 (10)	pF
$\overline{OE}/V_{PP}$	C <sub>IN2</sub>		-	-	60	
Output	C <sub>OUT</sub>	V <sub>O</sub> =0V	-	-	10 (12)	

( ) : DIP only

## ELECTRICAL CHARACTERISTICS (Programming operation)

### DC Characteristics

(Ta=25°C±5°C)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input leakage current	I <sub>LI</sub>	V <sub>I</sub> =V <sub>CC</sub> +0.5V	-	-	10	μA
V <sub>PP</sub> power supply current (Program)	I <sub>PP2</sub>	$\overline{CE}=V_{IL}$	-	-	50	mA
V <sub>CC</sub> power supply current	I <sub>CC</sub>	-	-	-	50	mA
Input "H" level	V <sub>IH</sub>	-	3.0	-	V <sub>CC</sub> +0.5	V
Input "L" level	V <sub>IL</sub>	-	-0.5	-	0.8	V
Output "H" level	V <sub>OH</sub>	I <sub>OH</sub> =-400μA	2.4	-	-	V
Output "L" level	V <sub>OL</sub>	I <sub>OL</sub> =2.1mA	-	-	0.45	V
Program voltage	V <sub>PP</sub>	-	9.5	9.75	10.0	V
V <sub>CC</sub> power supply voltage	V <sub>CC</sub>	-	3.9	4.0	4.1	V

Voltage is relative to V<sub>SS</sub>

### AC Characteristics

(V<sub>CC</sub>=4.0V±0.1V, V<sub>pp</sub>=9.75V±0.25V, Ta=25°C±5°C)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Address set-up time	T <sub>AS</sub>	-	100	-	-	ns
Data set-up time	T <sub>DS</sub>	-	100	-	-	ns
Address hold time	T <sub>AH</sub>	-	2	-	-	μs
Data hold time	T <sub>DH</sub>	-	100	-	-	ns
Output float delay from $\overline{CE}$	T <sub>CHZ</sub>	-	0	-	100	ns
V <sub>PP</sub> voltage set-up time	T <sub>VS</sub>	-	2	-	-	μs
Program pulse width	T <sub>PW</sub>	-	9	10	11	μs
Data valid from $\overline{CE}$	T <sub>CE</sub>	-	-	-	100	ns
Address hold from $\overline{CE}$ high	T <sub>AHC</sub>	-	0	-	-	ns
V <sub>PP</sub> voltage recovery time	T <sub>VR</sub>	-	2	-	-	μs

### Pin Check Function

Pin Check Function is to check contact between each device-pin and each socket-lead with EPROM programmer.

Setting up address as the following condition call the preprogrammed codes on device outputs.

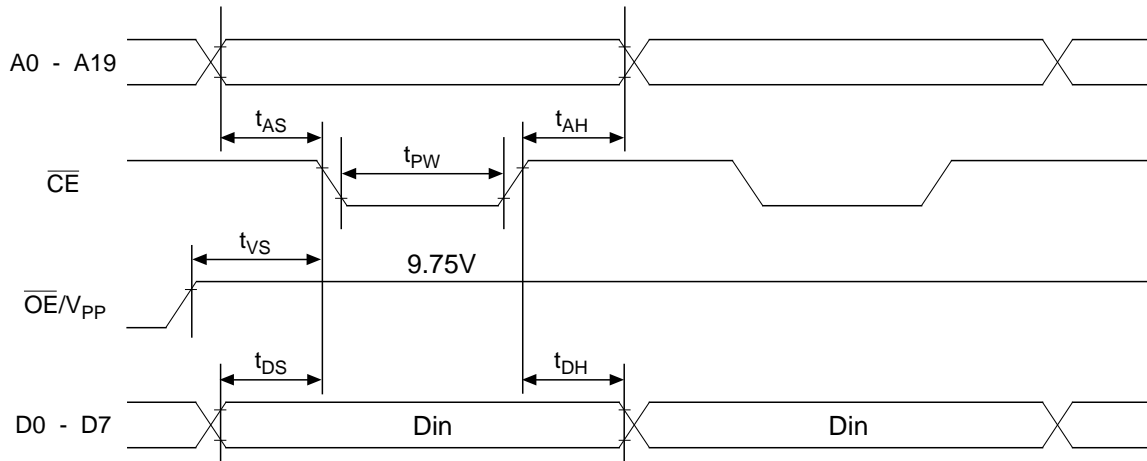
(V<sub>CC</sub>=3.3V±0.3V,  $\overline{CE}=V_{IL}$ ,  $\overline{OE}/V_{pp}=V_{IL}$ , Ta=25°C±5°C)

A0	A1	A2	A3	A4	A5	A6	A7	A8	A9	A10	A11	A12	A13	A14	A15	A16	A17	A18	A19	DATA
0	1	0	1	0	1	0	1	0	VH*	1	1	0	1	0	1	0	1	0	1	AA
1	0	1	0	1	0	1	0	1	VH*	0	0	1	0	1	0	1	0	1	0	55
Other conditions																				FF

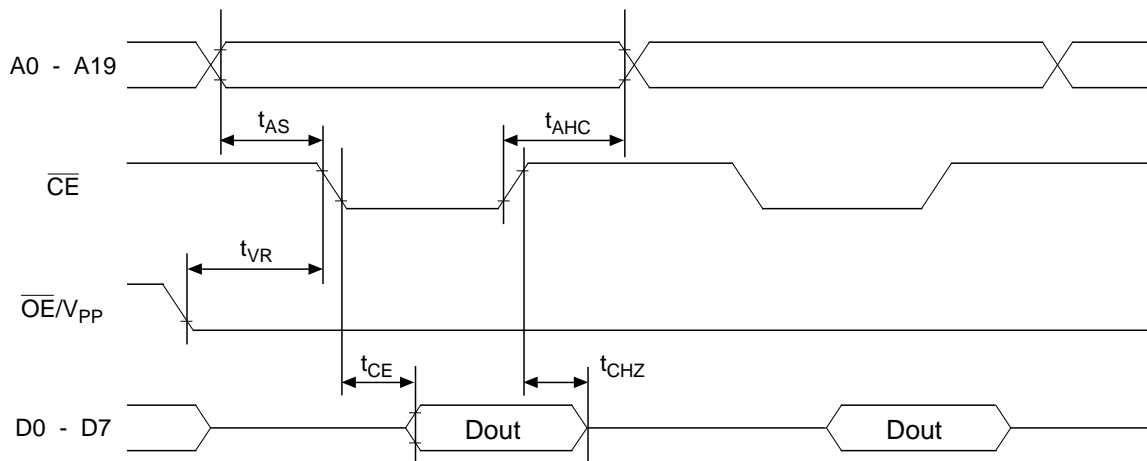
\*: VH=8V±0.25V



### Consecutive Programming Waveforms

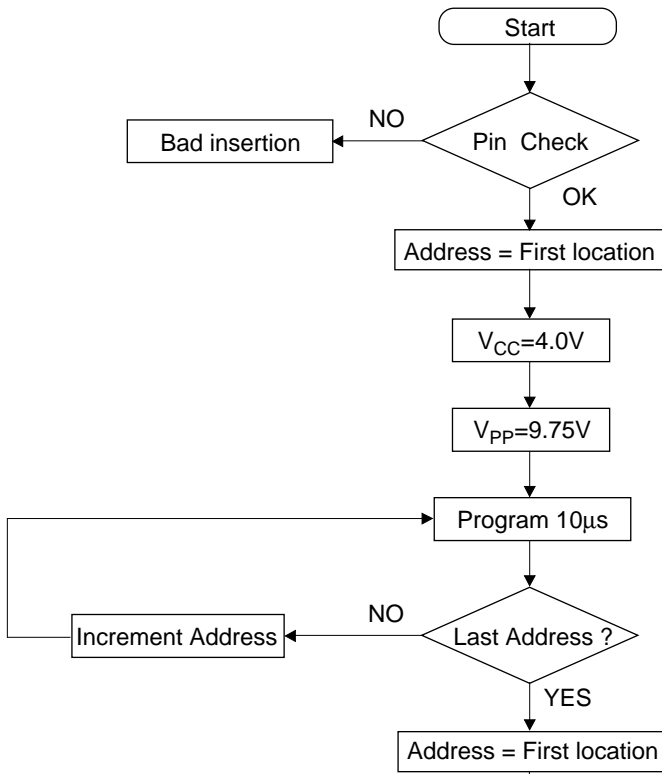


### Consecutive Program Verify Waveforms



Programming / Verify Flow Chart

Programming



Verify

